

# SLOVENSKI STANDARD oSIST prEN IEC 60060-1:2023

01-maj-2023

# Visokonapetostne preskusne tehnike - 1. del: Splošne definicije in preskusne zahteve

High-voltage test techniques - Part 1: General definitions and test requirements

Hochspannungs-Prüftechnik - Teil 1: Allgemeine Begriffe und Prüfbedingungen

Technique des essais à haute tension - Partie 1: Définitions et exigences générales

Ta slovenski standard je istoveten z: prEN IEC 60060-1:2023

### ICS:

17.220.20 Merjenje električnih in magnetnih veličin
19.080 Električno in elektronsko preskušanje

Measurement of electrical and magnetic quantities Electrical and electronic testing

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# 42/414/CDV

### COMMITTEE DRAFT FOR VOTE (CDV)

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42/403/CD, 42/409/CC

IEC TC 42 : HIGH-VOLTAGE AND HIGH-CURRENT TEST TECHNIQUES				
SECRETARIAT:	SECRETARY:			
Canada	Mr Howard G. Sedding			
OF INTEREST TO THE FOLLOWING COMMITTEES:	PROPOSED HORIZONTAL STANDARD:			
TC 14,TC 17,SC 17A,SC 17C,SC 18A,TC 23,TC	$\boxtimes$			
32,TC 36,TC 37,TC 38,TC 122	Other TC/SCs are requested to indicate their interest, if any, in this CDV to the secretary.			
FUNCTIONS CONCERNED:				
EMC ENVIRONMENT	QUALITY ASSURANCE SAFETY			
	NOT SUBMITTED FOR CENELEC PARALLEL VOTING			
Attention IEC-CENELEC parallel voting				
The attention of IEC National Committees, members of CENELEC, is drawn to the fact that this Committee Draft for Vote (CDV) is submitted for parallel voting.				
The CENELEC members are invited to vote through the CENELEC online voting system.	<u>C60060-1:2023</u> ards/sist/60fb6796-48e8-49d7-9088-			

95bd7d19f/osist-pren-iec-60060-1-202

This document is still under study and subject to change. It should not be used for reference purposes.

Recipients of this document are invited to submit, with their comments, notification of

- any relevant patent rights of which they are aware and to provide supporting documentation,
- any relevant "in some countries" clauses to be included should this proposal proceed. Recipients are reminded that the enquiry stage is the final stage for submitting "in some countries" clauses. See AC/22/2007.

### TITLE:

### High-voltage test techniques - Part 1: General definitions and test requirements

PROPOSED STABILITY DATE: 2027

NOTE FROM TC/SC OFFICERS:

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170		INTERNATIONAL ELECTROTECHNICAL COMMISSION	
171			
172			
173		HIGH-VOLTAGE TEST TECHNIQUES -	
174		Part 1: General definitions and test requirements	
175		Fait 1. General definitions and test requirements	
177			
178		FOREWORD	
179 180 181 182 183 184 185 186 187	1)	The International Electrotechnical Commission (IEC) is a worldwide organization for standardization comprising all national electrotechnical committees (IEC National Committees). The object of IEC is to promote international co-operation on all questions concerning standardization in the electrical and electronic fields. To this end and in addition to other activities, IEC publishes International Standards, Technical Specifications, Technical Reports, Publicly Available Specifications (PAS) and Guides (hereafter referred to as "IEC Publication(s)"). Their preparation is entrusted to technical committees; any IEC National Committee interested in the subject dealt with may participate in this preparatory work. International, governmental and non-governmental organizations liaising with the IEC also participate in this preparation. IEC collaborates closely with the International Organization for Standardization (ISO) in accordance with conditions determined by agreement between the two organizations.	
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211 212	International Standard IEC 60060-1 has been prepared by IEC Technical Committee 42: High- voltage and high-current test techniques.		
213 214	This fourth edition of IEC 60060-1 cancels and replaces the third edition, published in 2010, and constitutes a technical revision.		
215	Th	e significant technical changes with respect to the previous edition are as follows:	
216 217	a)	The general layout and text were updated and improved to make the standard easier to use, particularly the chapters for combined and composite test voltages.	
218 219	b)	The positive tolerance of the front time of lightning impulse was extended for $U_m$ > 800 kV to 100 % (= 2,4 µs)	
220 221 222	c)	For switching impulse voltage, a front time was introduced, similar to lightning impulse voltage and with the new front time the standard switching impulse is defined as 170/2500 $\mu s.$	
223	d)	The requirements for precipitations were adjusted depending on $U_{\rm m}$ .	

e) Annex C "Procedure for manual calculation from graphical waveforms" was incorporated.

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- f) No examples for software were given in Annex D "Guidance for implementing software for evaluation of lightning impulse voltage parameters"
- 227 g) Annex about "Background to the introduction of the test voltage factor for evaluation of 228 impulses with overshoot" was deleted.
- h) A new informative Annex F "New definition of the front time of switching impulse voltage"
   was incorporated.
- 231

FDIS	Report on voting
42/xx/FDIS	42/xx/RVD

232

Full information on the voting for the approval of this document can be found in the report on voting indicated in the above table.

This publication has been drafted in accordance with the ISO/IEC Directives, Part 2

A list of all the parts in the IEC 60060 series, under the general title *High-voltage and highcurrent test techniques*, can be found on the IEC website.

The committee has decided that the contents of this publication will remain unchanged until the stability date indicated on the IEC website under "http://webstore.iec.ch" in the data related to this specific publication. At this date, the publication will be:

- reconfirmed;
- withdrawn;
- replaced by a revised edition or
- amended.
- 245 https://standards.iteh.ai/catalog/standards/sist/60fb6796-48e8-49d7-9088b4195bd7d19f/osist-pren-iec-60060-1-2023
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247	HIGH-VOLTAGE TEST TECHNIQUES –
248	
249	Part 1: General definitions and test requirements
250	
251	
252	
253	1 Scope
254	This part of IEC 60060 is applicable to:
255	<ul> <li>dielectric tests with direct voltage;</li> </ul>
256	<ul> <li>dielectric tests with alternating voltage;</li> </ul>
257	<ul> <li>dielectric tests with impulse voltage;</li> </ul>
258	<ul> <li>dielectric tests with combinations of the above.</li> </ul>
259	This part is applicable to tests on equipment having its highest voltage for equipment $U_m$ above
260	1 kV AC and 1,5 kV DC.
261 262	NOTE 1 Alternative test procedures may be required to obtain reproducible and significant results. The choice of a suitable test procedure is considered by the relevant Technical Committee.
263 264	NOTE 2 For voltages $U_{\rm m}$ above 800 kV some specified procedures, tolerances and uncertainties may not be achievable.
265	2 Normative references Standards.iteh.ai)
266	The following referenced documents are indispensable for the application of this document. For
267 268	dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.
269	IEC 60060-2, High-voltage test techniques – Part 2: Measuring systems
270	IEC 60270, High-voltage test techniques – Partial discharge measurements
271	IEC 60507, Artificial pollution tests on high-voltage insulators to be used on a.c. systems
272	IEC 61083-1, Instruments and software used for measurements in high-voltage and high-
273	current tests - Part 1: Requirements for instruments for impulse tests
274 275	IEC 61083-2, Instruments and software used for measurement in high-voltage and high-current tests - Part 2: Requirements for software for tests with impulse voltages and currents
276 277	IEC 61083-3, Instruments and software used for measurement in high-voltage and high-current tests - Part 3: Requirements for software for tests with impulse voltages and currents
278 279	IEC 62475, High-current test techniques: Definitions and requirements for test currents and measuring systems

#### 3 Terms and definitions 280

For the purposes of this document, the following terms and definitions apply. 281

	IEC CDV 60060-1/Ed4 © IEC: 2023 - 8 - 42/414/CDV
282	3.1 Definitions related to characteristics of discharges
283 284 285 286	<b>3.1.1</b> <b>disruptive discharge</b> phenomenon associated with the failure of insulation under electrical stress which includes a collapse of voltage and the passage of current
287 288	Note 1 to entry: The term applies to electric breakdown in solid, liquid and gaseous dielectrics and combination of these.
289 290	Note 2 to entry: A disruptive discharge in a solid dielectric produces permanent loss of dielectric strength; in a liquid or gaseous dielectric the loss of dielectric strength can be temporary.
291	[IEV 614-03-16, modified in Note 2 to entry]
292 293 294	<b>3.1.2</b> <b>sparkover</b> disruptive discharge in a gaseous or liquid insulating material
295	[IEV 212-11-48]
296 297 298 299	<b>3.1.3</b> <b>flashover</b> electric breakdown between conductors in a gas or a liquid or in vacuum, at least partly along the surface of solid insulation
300	[IEV 212-11-47] (standards.iteh.ai)
301	3.1.4
302	puncture
303 304	disruptive discharge occurring through a solid insulation material, producing a path of permanent damage inderest ten al/catalog/standards/sist/001b6796-4888-49d7-9088-
305	Note 1 to entry: The term puncture is also used as a synonym for electric breakdown in solids.
306	[IEV 212-11-49]
307 308 309 310	<b>3.1.5</b> <b>disruptive discharge voltage value</b> value of the test voltage causing disruptive discharge, as specified, for the various tests, in the relevant clauses of the present document
311 312 313 314	<b>3.1.6</b> <b>non-disruptive discharge</b> discharge between intermediate electrodes or conductors where the test voltage does not collapse to zero
315 316	Note 1 to entry: Such an event is not considered as a disruptive discharge unless so specified by the relevant Technical Committee.
317	Note 2 to entry: Some non-disruptive discharges are termed "partial discharges" and are dealt with in IEC 60270.

### 318 3.2 Definitions related to characteristics of the test voltage

### 319 **3.2.1**

### 320 prospective characteristics

characteristics which would have been obtained if no disruptive discharge had occurred and when a prospective characteristic is used and this shall always be stated

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### 323 **3.2.2**

### 324 actual characteristics

325 those characteristics which occur during the test at the terminals of the test object

### 326 **3.2.3**

### 327 value of the test voltage

328 as defined in the relevant clauses of this document

### 329 **3.2.4**

### 330 withstand voltage

- specified prospective voltage value which characterizes the insulation of the object with regard
   to a withstand test
- Note 1 to entry: Unless otherwise specified, withstand voltages are referred to standard reference atmospheric
   conditions (see Clause 4.3.1) which applies to external insulation only.

### 335 **3.2.5**

### 336 assured disruptive discharge voltage

specified prospective voltage value which characterizes its performance with regard to a
 disruptive discharge test

#### 339 **3.2.6**

### 340 voltage dip

- a sudden reduction of the voltage at a point in an electrical system followed by voltage recovery
   after a short period of time from a few cycles to a few seconds
- 343 [IEV 161-08-10]

# (standards.iteh.ai)

### 344 3.3 Definitions related to tolerance and uncertainty

- 345 3.3.1 https://standards.iteh.ai/catalog/standards/sist/60fb6796-48e8-49d7-9088-
- 346 **tolerance** b4195bd7d19f/osist-pren-jec-60060-1-2023
- 347 constitutes the permitted difference between the measured value and the specified value
- 348 Note 1 to entry: This difference has to be distinguished from the uncertainty of a measurement.
- Note 2 to entry: A pass/fail decision is based on the measured value, without consideration of the measurement uncertainty.

### 351 **3.3.2**

### 352 uncertainty (of measurement)

- parameter, associated with the result of a measurement, that characterizes the dispersion of the values that could be reasonably attributed to the measurand
- 355 [IEV 311-01-02 with modified notes]
- Note 1 to entry: In this document, all uncertainty values are specified at a level of confidence of 95 %.
- 357 Note 2 to entry: Uncertainty is positive and given without sign.
- 358 Note 3 to entry: It is not be confused with the tolerance of a test-specified value or parameter.

# 359 3.4 Definitions related to statistical characteristics of disruptive discharge voltage 360 values

#### 361 **3.4.1**

### 362 disruptive discharge probability

- 363 **p**
- 364 probability that an application of a certain prospective voltage value of a given shape will cause 365 disruptive discharge on the test object

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366	Note 1 to entry: The parameter $p$ is usually expressed as	a percentage or a fraction.		
367 368 369	3.4.2 withstand probability			
370 371	probability that an application of a certain prospective discharge on the test object	pective voltage value of a giver	n shape does not	
372	Note 1 to entry: If the disruptive discharge probability is p	, the withstand probability $q$ is $(1 - p)$ .		
373 374 375	3.4.3 <i>p %</i> disruptive discharge voltage U <sub>p</sub>			
376 377	prospective voltage value which has $p$ % probatest object	bility of producing a disruptive	discharge on the	
378 379	Note 1 to entry: Mathematically the $p~\%$ disruptive dischathe breakdown voltage.	rge voltage is the quantile of the orde	er p (or p quantile) of	
380 381	Note 2 to entry: $U_{10}$ is called the "statistical withstand voltage" and $U_{90}$ is called the "statistical assured disruptive discharge voltage".			
382 383 384	3.4.4 50 % disruptive discharge voltage <i>U</i> <sub>50</sub>			
385 386	prospective voltage value which has a 50 % pr the test object	obability of producing a disrupt	tive discharge on	
387	3.4.5 (Stalluaro			
388 389	arithmetic mean value of the disruptive disc U <sub>a</sub> <u>oSIST prEN IE</u>	harge voltage <u>C 60060-1:2023</u>		
	https://standards.iteh.ai/catalog/stand $u = 1 \sum_{n=1}^{n} u = b4195 bd7d19 f/osist-r$			
390	$O_{a} = -\frac{1}{n} \sum_{i=1}^{n} O_{i} $ (1)			
391	where			
392	$U_i$ is the measured disruptive discharge volt	age and		
393	<i>n</i> is the number of discharges.			
394	Note 1 to entry: For symmetric distributions $U_a$ is identicated as the symmetric distribution of the symmetric distribution of the symmetries of the symm	I to U <sub>50</sub>		
395 396	3.4.6 standard deviation of the disruptive voltage			
397 398	<i>s</i> a measure of the dispersion of the disruptive di	scharge voltage estimated by		
399	$s = \sqrt{\frac{1}{n-1} \sum_{i=1}^{n} (U_i - U_a)^2} $ (2)			

400 where

401  $U_i$  is the *i*<sup>th</sup> measured disruptive discharge voltage and

402  $U_{\rm a}$  is the arithmetic mean of the disruptive discharge voltages

403 *n* is the number of observations (discharges).

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42/414/CDV

404 Note 1 to entry: It can also be evaluated by the difference between the 50 % and 16 % disruptive discharge voltages 405 (or between the 84 % and 50 % disruptive discharge voltages). It is often expressed in per unit or percentage value 406 referred to the 50 % disruptive discharge voltage.

407 Note 2 to entry: For successive disruptive discharge tests the standard deviation s is defined by the formula. For 408 multiple level and up-and-down tests, it is defined by the difference of the quantiles. The methods are equivalent 409 because, between p = 16 % and p = 84 % all distribution functions are nearly identical.

### 410 **3.5 Definitions related to classification of insulation in test objects**

411 **3.5.1** 

### 412 external insulation

- air insulation and the exposed surfaces of solid insulation of the equipment, which are subject
- both to dielectric stresses and to the direct effects of atmospheric and other environmental conditions
- 416 Note 1 to entry: Examples of environmental conditions are pollution and humidity.

### 417 **3.5.2**

### 418 internal insulation

internal solid, liquid or gaseous elements of the insulation of equipment protected from thedirect effects of external conditions such as pollution and humidity

### 421 **3.5.3**

### 422 self-restoring insulation

- insulation which completely recovers its insulating properties within a short time interval after a
   disruptive discharge
- 425 [IEV 614-03-04]

# (standards.iteh.ai)

#### 426 **3.5.4**

- 427 non-self-restoring insulation <u>oSIST prEN IEC 60060-1:2023</u>
- 428 insulation which loses its insulating properties, or does not recover them completely, after a
- 429 disruptive discharge b4195bd7d19f/osist-pren-iec-60060-1-2023
- 430 [IEV 614-03-05]

431 Note 1 to entry: In test objects, parts of both self-restoring and non-self-restoring insulation are always operating in 432 combination and some parts may be degraded by repeated or continued voltage applications. The behaviour of the 433 insulation in this respect should is taken into account by the relevant Technical Committee when specifying the test

434 procedures to be applied.

### 435 **4 General requirements**

### 436 **4.1 General requirements for test procedures**

The test procedures applicable to particular types of test objects, for example, the test voltage, the polarity to be used, the preferred order if both polarities are to be used, the number of applications and the interval between applications shall be specified by the relevant Technical Committee, having regard to such factors as:

- 441 the required measurement uncertainty;
- 442 the random nature of the observed phenomena;
- 443 any polarity dependence of the measured characteristics;
- 444 the possibility of progressive deterioration with repeated voltage applications.

At the time of a test, the test object shall be complete in all essential details, and it should have been processed in the normal manner for similar test objects. IEC CDV 60060-1/Ed4 © IEC: 2023 - 12 -

At the time of a test, the test object should have become acclimatised as much as practicable to the ambient atmospheric conditions of the test area. The period allocated to reach equilibrium should be recorded.

### 450 **4.2** Arrangement of the test object in dry tests

The disruptive discharge characteristics of a test object with external insulation may be affected by its general arrangement (for example, proximity effects such as distance in air from other live or earthed structures, height above ground level and the arrangement of its high-voltage lead). The general arrangement should be specified by the relevant Technical Committee.

NOTE 1 A clearance to extraneous structures not less than 1,5 times the length of the shortest possible discharge path on the test object usually makes such proximity effects negligible. In wet or pollution tests, or wherever the voltage distribution along the test object and the electric field around its energized electrode are sufficiently independent of external influences, smaller clearances may be acceptable, provided that discharges do not occur to extraneous structures.

460 NOTE 2 In the case of AC or positive switching impulse voltage tests above 750 kV (peak) the influence of an 461 extraneous structure may be considered as negligible if its distance from the energized electrode is also not less 462 than the height of this electrode above the ground plane. A guide for recommended minimum clearance is given in 463 Figure 1, as a function of the highest test voltage. Significant shorter clearances may be suitable in individual cases. 464 However, an experimental adaptation or an electric field calculation, taking into account voltage dependent maximum 465 field strength as described in the literature, is recommended.





### Figure 1 – Recommended minimum clearance *D* of extraneous live or earthed objects to the energized electrode of a test object, during an AC or positive switching impulse test at the maximum voltage *U* applied during test

If not otherwise specified by the relevant Technical Committee, the test should be made at
ambient atmospheric conditions in the test area without extraneous precipitation or pollution.
The procedure for voltage application shall be as specified in the relevant clauses of this
document.

### 474 **4.3** Atmospheric corrections in dry tests

### 475 4.3.1 Standard reference atmosphere

476 The standard reference atmosphere is:

- 477 temperature  $t_0 = 20$  °C;
- 478 absolute pressure  $p_0 = 1.013 \text{ hPa} (1.013 \text{ mbar});$
- 479 <sup>–</sup> absolute humidity  $h_0 = 11 \text{ g/m}^3$ .

NOTE 1 An absolute pressure of 1 013 hPa corresponds to the height of 760 mm of the mercury column in a mercury
 barometer at 0 °C. If the barometer height is *H* mm of mercury, the atmospheric pressure in hectopascal is
 approximately